# TOSHIBA MOS MEMORY PRODUCTS

1 MEGA BIT (131,072 WORD×8 BIT) CMOS U.V. ERASABLE AND ELECTRICALLY PROGRAMMABLE READ ONLY MEMORY SILICON STACKED GATE MOS

TC571000D-17, -20, -200, -25 TC571001D-17, -20, -200, -25

### DESCRIPTION

The TC571000D/TC571001D is a 131,072 word x 8 bit CMOS ultraviolet light erasable and electrically programmable read only memory.

The TC571000D is JEDEC standard pin configuration and the TC571001D is compatible with 28 pin 1M bit Mask ROM. Both products are packed in 32 pin standard cerdip package. TC571000D/TC571001D is fabricated with the CMOS technology. Advanced circuit techniques

provide both high speed and low power features with a maximum operating current of 30mA/5.9MHz and access time of 170ns/200ns/250ns.

The programming times of the TC571000D/TC571001 D except overhead times of EPROM programmer is only 14 seconds by using the high speed programming algorithm.

### **FEATURES**

 Peripheral circuit: CMOS Memory cell : N-MOS

Access Time

|       | -17         | -20     | -25   | 200      |
|-------|-------------|---------|-------|----------|
| Vcc   |             | 5V ± 5% |       | 5∨ ± 10% |
| Temp  | -40 ~ 85° C |         |       | 0 ~ 70°C |
| t ACC | 170ns       | 200ns   | 250ns | 200ns    |

Low power dissipation

Active : 30mA/5.9MHzStandby:  $100\mu\text{A}$  (Ta =  $85^{\circ}$  C) Single 5V power supply

Wide operating temperature range: −40 ~ 85°C

Full static operation

• High speed programming operation: tpw 0.1ms

Input and output TTL compatible
JEDEC standard 32 pin: TC571000D
1M MROM compatible: TC571001D

Standard 32 pin DIP cerdip package

### PIN CONNECTION (TOP VIEW)

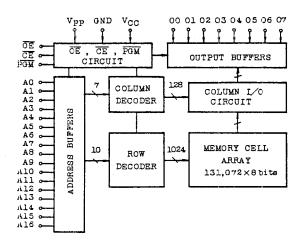
|       |        | <del></del>    |                 | / <del></del> 7 |    |
|-------|--------|----------------|-----------------|-----------------|----|
| VPP ( |        | 32 JI VCC      | VPP 📮 1         | osa pivec       |    |
| A16 1 | 2      | 31 P P W       | ठइ ० 2          | 37 1 LGM        |    |
| A15   | 3      | 30 D NC        | A15 [3          | 30 рис          | A. |
| A12   | 4      | 29 A14         | A12 04          | 29 A 14         | A. |
| A7    | 5      | 28 1 A13       | A7 🕻 5          | 29 A 13         |    |
| A6    | 16     | 27 A8          | AG [ G          | 27 D A8         |    |
| A5    | 7      | 26 A9          | A5 [7           | 26 J A9         | 4  |
|       | da e   | 25 All         | A4 L8           | 25 <b>)</b> All |    |
| A3    | d s    | 24 ] OE        | A3 t 9          | 24 DA16         |    |
| A2    | 10     | 23 A10         | A2 [ 10         | 23 <b>7</b> A10 |    |
| Al    | 111    | 22 I CE        | יום גא          | 22 D CE         |    |
| AO    | 12     | 21 D D7        | AO 🛭 12         | 21 D7           |    |
| DO    | 13     | 20 D D6        | DO <b>1</b> 13  | 20 D D6         |    |
| Dl    | d 14.  | 19 D D5        | D1 114          | 19 <b>)</b> D5  |    |
| D2    | 15     | 18 1 D4        | D2 <b>C</b> 15  | 13 D4           |    |
| GND   | 16     | 17 <b>1</b> D3 | GND (16         | 17 D3           | G  |
|       |        |                | · · · · · · · · |                 |    |
|       | TC5710 | 000D           | TC571           | .001D           |    |

| /     |               |      |        |
|-------|---------------|------|--------|
| (1)   | lefere        | nce  | :)     |
| A15 d | $\overline{}$ |      | vcc    |
| A12 C | 2             | 27   | A14    |
| A7 [  | 3             | 26   | 1 A13  |
| A6 C  | 4             | 25   | 8A [   |
| A5 [  | 5             | 24   | 3 A 9  |
| A4 0  |               | 23   | 1 All  |
| A3 D  |               | 22   | 1 A 16 |
| A2 C  |               | 21   | D A 10 |
| Al C  |               | 20   | CE     |
| AO I  |               | 19   | דם ב   |
| DO [  | 11            | 18   | li D6  |
| D1 [  | 12            | 17   | D D5   |
| D2 (  | 13            | 16   | D4     |
| GND ( | 14            | 15   | D3     |
| Ç     | IM Mas        | sk 1 | ROM)   |

### PIN NAMES

| A0 ~ A16        | Address Inputs         |
|-----------------|------------------------|
| D0 ~ D7         | Output (Inputs)        |
| CE              | Chip Enable Input      |
| ŌĒ              | Output Enable Input    |
| FGM             | Program Control Input  |
| Vcc             | Power Supply Voltage   |
| V <sub>PP</sub> | Program Supply Voltage |
| GND             | Ground                 |
| NC              | No Connection          |

### **BLOCK DIAGRAM**



### MODE SELECTION

| PIN              | PGM        | CE | ŌE             | V <sub>PP</sub> | Vcc   | 00 ~ 07        | POWER    |  |
|------------------|------------|----|----------------|-----------------|-------|----------------|----------|--|
| Read             | H          | L  | L              |                 |       | Data Out       |          |  |
| Output Deselect  | *          | *  | Н              | 5V              | 5V    | High Impedance | - Active |  |
| Standby          | y * H *    |    | High Impedance | Standby         |       |                |          |  |
| Program          | L          | L  | Н              |                 |       | Data In        |          |  |
| December Inhibit | *          | Н  | *              | 12.75V          | 6.25V | High Impedance | <b>7</b> |  |
| Program Inhibit  | Н          | L  | Н              | 12.750          | 6.25V | High Impedance | - Active |  |
| Program Verify   | Н          | L  | L              | 1               |       | Data Out       |          |  |
|                  | * : H or ! | -  | 1              |                 | 1     |                |          |  |

### MAXIMUM RATINGS

| SYMBOL           | ITEM                         | RATING                   | UNIT   |
|------------------|------------------------------|--------------------------|--------|
| Vcc              | Power Supply Voltage         | <b>−0.6</b> ~ 7.0        | V      |
| V <sub>PP</sub>  | Program Supply Voltage       | 0.6 ∼ 14.0               | V      |
| VIN              | Input Voltage                | -0.6 ~ 7.0               | V      |
| V <sub>I/O</sub> | Input/Output Voltage         | $-0.6 \sim V_{CC} + 0.5$ | V      |
| P <sub>D</sub>   | Power Dissipation            | 1.5                      | W      |
| TSOLDER          | Soldering Temperature • Time | 260•10                   | °C•sec |
| $T_{STG}$        | Storage Temperature          | <b>−</b> 65 ~ 125        | °C     |
| T <sub>OPR</sub> | Operating Temperature        | <b>−40</b> ~ 85          | °C     |

### READ OPERATION

### D.C. RECOMMENDED OPERATING CONDITIONS

| CVMDOL          | DADAMETER                            | TC571000              | TC571000D/1001D-17, -20, -25 |                       |                | TC571000D/1001D-200 |                       |      |  |
|-----------------|--------------------------------------|-----------------------|------------------------------|-----------------------|----------------|---------------------|-----------------------|------|--|
| SYMBOL          | PARAMETER                            | MIN.                  | TYP.                         | MAX.                  | MIN.           | TYP.                | MAX.                  | UNIT |  |
| V <sub>IH</sub> | Input High Voltage                   | 2.2                   | _                            | V <sub>CC</sub> + 0.3 | 2.2            |                     | V <sub>CC</sub> + 0.3 |      |  |
| VIL             | Input Low Voltage                    | 0.3                   |                              | 0.8                   | 0.3            |                     | 0.8                   | \ \/ |  |
| Vcc             | V <sub>CC</sub> Power Supply Voltage | 4.75                  | 5.00                         | 5.25                  | 4.50           | 5.00                | 5.50                  | ľ    |  |
| V <sub>PP</sub> | V <sub>PP</sub> Power Supply Voltage | V <sub>CC</sub> - 0.6 | Vcc                          | $V_{CC} + 0.6$        | $V_{CC} - 0.6$ | Vcc                 | V <sub>CC</sub> + 0.6 |      |  |

### D.C. AND OPERATING CHARACTERISTICS (Ta = -40 ~ 85°C)

| SYMBOL            | PARAMETER               | TEST CONDITION                               | MIN. | TYP. | MAX. | UNIT |
|-------------------|-------------------------|--|------|------|------|------|
| ILI               | Input Current           | $V_{IN} = 0 \sim V_{CC}$                     |      |      | ±10  | μΑ   |
| Icco1             | 0                       | CE = 0V f = 5.9 MHz                          |      |      | 30   | mA   |
| Icco2             | Operating Current       | $I_{OUT} = 0 \text{ mA}$ $f = 1 \text{ MHz}$ |      | T -  | 10   | mA   |
| CCS1              | - Standby Current       | CE = V <sub>IH</sub>                         |      | _    | 1    | mA   |
| 1 <sub>CCS2</sub> | - Standby Current       | $\overline{CE} = V_{CC} - 0.2V$              |      | -    | 100  | μA   |
| V <sub>OH</sub>   | Output High Voltage     | $I_{OH} = -400 \mu\text{A}$                  | 2.4  |      | _    | V    |
| VoL               | Output Low Voltage      | I <sub>OL</sub> = 2.1 mA                     |      | _    | 0.4  | V    |
| l PP1             | V <sub>PP</sub> Current | $V_{PP} = V_{CC} \pm 0.6V$                   |      |      | ±10  | μΑ   |
| 1 LO              | Output Leakage Current  | V <sub>OUT</sub> = 0.4V ~ ∨                  |      | _    | 10   | μΑ   |

 $Ta = 0 \sim 70^{\circ} C$  for TC571000D/1001D-200

# **A.C. CHARACTERISTICS** (Ta = $-40 \sim 85^{\circ}$ C, $V_{PP} = V_{CC} \pm 0.6V$ )

| SYMBOL           | PARAMETER               |      | TC571000D/<br>1001D-17 |      | TC571000D/<br>1001D-20, -200 |      | TC571000D/<br>1001D-25 |       |
|------------------|-------------------------|------|------------------------|------|------------------------------|------|------------------------|-------|
|                  |                         | MIN. | MAX.                   | MIN. | MAX.                         | MIN. | MAX.                   | 1     |
| t <sub>ACC</sub> | Address Access Time     | _    | 170                    |      | 200                          |      | 250                    |       |
| t <sub>CE</sub>  | CE to Output Valid      | _    | 170                    |      | 200                          |      | 250                    | 1     |
| t <sub>OE</sub>  | OE to Output Valid      |      | 70                     | -    | 70                           |      | 100                    |       |
| <sup>†</sup> PGM | PGM to Output Valid     |      | 70                     | _    | 70                           |      | 100                    | ns    |
| t <sub>DF1</sub> | CE to Output in High-Z  | 0    | 60                     | 0    | 60                           | 0    | 90                     | 7 115 |
| t <sub>DF2</sub> | OE to Output in High-Z  | 0    | 60                     | 0    | 60                           | 0    | 90                     |       |
| t <sub>DF3</sub> | PGM to Output in High-Z | 0    | 60                     | 0    | 60                           | 0    | 90                     |       |
| ton              | Output Data Hold Time   | 0    | -                      | 0    |                              | 0    |                        | 7     |

 $Ta = 0 \sim 70^{\circ} C \text{ for TC571000D/1001D-200}$ 

### A.C. TEST CONDITIONS

Output Load : 1 TTL Gate and  $C_L = 100pF$ 

Input Pulse Rise and Fall Times : 10ns Max.
Input Pulse Levels : 0.45V to 2.4V

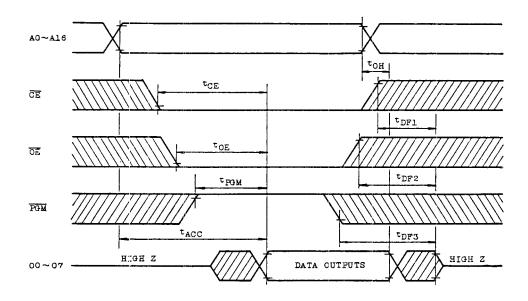
Timing Measurement Reference Level: Inputs 0.8V and 2.2V Outputs 0.8V and 2.0V

## CAPACITANCE \* (Ta = 25°C, f = 1MHz)

| SYMBOL           | PARAMETER          | TEST CONDITION        | MIN. | TYP. | MAX. | UNIT |
|------------------|--------------------|-----------------------|------|------|------|------|
| CIN              | Input Capacitance  | V <sub>IN</sub> = 0V  | _    | 4    | 8    | _    |
| C <sub>OUT</sub> | Output Capacitance | V <sub>OUT</sub> = 0V |      | 10   | 12   | p⊦   |

<sup>\*</sup> This parameter is periodically sampled and is not 100% tested.

# TIMING WAVEFORMS (READ)



### HIGH SPEED PROGRAM OPERATION

# D.C. RECOMMENDED OPERATING CONDITIONS

| SYMBOL          | PARAMETER                            | MIN.  | TYP.  | MAX.                  | UNIT |
|-----------------|--------------------------------------|-------|-------|-----------------------|------|
| VIH             | Input High Voltage                   | 2.2   | -     | V <sub>CC</sub> + 1.0 |      |
| VIL             | Input Low Voltage                    | -0.3  | _     | 0.8                   |      |
| V <sub>CC</sub> | V <sub>CC</sub> Power Supply Voltage | 6.00  | 6.25  | 6.50                  | ľ    |
| V <sub>PP</sub> | V <sub>PP</sub> Power Supply Voltage | 12.50 | 12.75 | 13.00                 |      |

# D.C. AND OPERATING CHARACTERISTICS (Ta = $25 \pm 5^{\circ}$ C, $V_{CC}$ = $6.25 \pm 0.25$ V, $V_{PP}$ = $12.75 \pm 0.25$ V)

| SYMBOL           | PARAMETE:R                     | TEST CONDITION           | MIN. | TYP. | MAX. | UNIT |
|------------------|--------------------------------|--------------------------|------|------|------|------|
| Tit              | Input Current                  | $V_{IN} = 0 \sim V_{CC}$ |      |      | ±10  | μΑ   |
| V <sub>OH</sub>  | Output High Voltage            | $I_{OH} = -400  \mu A$   | 2.4  | _    |      | V    |
| Vol              | Output Low Voltage             | I <sub>OL</sub> = 2.1 mA |      |      | 0.4  | V    |
| Icc              | V <sub>CC</sub> Supply Current | _                        |      |      | 30   | mA   |
| I <sub>PP2</sub> | V <sub>PP</sub> Supply Current | V <sub>PP</sub> = 13.0V  | _    | _    | 50   | mA   |
| V <sub>ID</sub>  | A9 Auto Select Voltage         |                          | 11.5 | 12.0 | 12.5 | V    |

# **A.C. PROGRAMMING CHARACTERISTICS** (Ta = $25 \pm 5^{\circ}$ C, $V_{CC} = 6.25 \pm 0.25$ V, $V_{PP} = 12.75 \pm 0.25$ V)

| SYMBOL           | PARAMETER                  | TEST CONDITION | MIN.  | TYP. | MAX.  | UNIT       |
|------------------|----------------------------|----------------|---|------|-------|------------|
| t <sub>AS</sub>  | Address Setup Time         | _              | - 2   |      |       | μs         |
| <sup>†</sup> AH  | Address Hold Time          | _              | 2   |      | μs    |            |
| tces             | CE Setup Time              |                | 2   |      | _     | μs         |
| tCEH             | CE Hold Time               | _              | -     2     -     -       -     2     -     -       -     2     -     -       -     2     -     -       -     2     -     -       -     2     -     -       -     0.095     0.1     0.105       -     -     -     100 |      | -     | μs         |
| t <sub>DS</sub>  | Data Setup Time            | _              | 2   |      |       | μs         |
| t <sub>DH</sub>  | Data Hold Time             | _              | 2   | _    |       | <b>μ</b> s |
| tvs              | V <sub>PP</sub> Setup Time | _              | 2   | -    | -     | μs         |
| tpw              | Program Pulse Width        | -              | 0.095   | 0.1  | 0.105 | ms         |
| toE              | OE to Output Valid         | <del>-</del>   |   |      | 100   | ns         |
| t <sub>DF2</sub> | OE to Output in High-Z     | CE = VIL       | -   | _    | 90    | ns         |

### A.C. TEST CONDITIONS

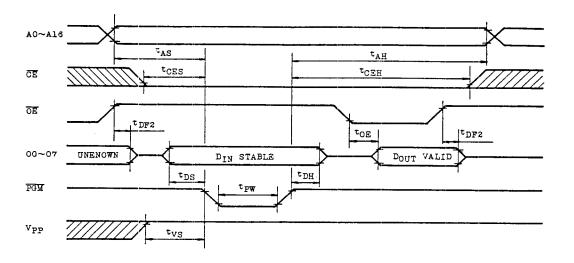
Output Load : 1 TTL Gate and C<sub>L</sub> (100pF)

Input Pulse Rise and Fall Time : 10ns Max.
Input Pulse Levels : 0.45V and 2.4V

Timing Measurement Reference Level: Input 0.8V and 2.2V, Output 0.8V and 2.0V

### HIGH SPEED PROGRAM OPERATION

### TIMING CHART



- NOTE: 1.  $V_{CC}$  must be applied simultaneously or before  $V_{PP}$  and cut off simultaneously or after  $V_{PP}$ .
  - 2. Removing the device from socket and setting the device in socket with  $V_{PP} = 12.75V$  may cause permanent damage to the device.
  - 3. The  $V_{PP}$  supply voltage is permitted up to 14V for program operation, so the voltage over 14V should not be applied to the  $V_{PP}$  terminal. When the switching pulse voltage is applied to the  $V_{PP}$  terminal, the overshoot voltage of its pulse should not be exceeded 14V.

### ERASURE CHARACTERISTICS

The TC571000D/571001D's erasure is achieved by applying shortwave ultraviolet light which has a wavelength of 2537Å (Angstroms) to the chip through the transparent window. Then integrated dose (Ultraviolet light intensity [W/cm²] x exposure time [sec.]) for erasure should be a minimum of 15 [W·sec/cm²]. sec/cm²].

When the Toshiba sterilizing lamp GL-15 is used and the device is exposed at a distance of 1cm from the lamp surface, the erasure will be achieved within 60 minutes. And using commercial lamps whose

### OPERATION INFORMATION

The TC571000D/TC571001D's six operation modes are listed in the following table. Mode selec-

ultraviolet light intensity is a 12000 [ $\mu$ W/cm<sup>2</sup>] will reduce the exposure time to about 20 minutes. (In this case, the integrated dose is 12000 [ $\mu$ W/cm<sup>2</sup>] x (20 x 60) [sec]  $\cong$  15 [W·sec/cm<sup>2</sup>].)

The TC571000D/TC571001D's erasure begins to occur when exposed to light with wavelength shorter than 4000Å. The sunlight and the flourescent lamps will include 3000 ~ 4000Å wavelength components. Therefore when used under such lighting for extended periods of time, the opeque seals — Toshiba EPROM Protect Seal AC901 — are available.

tion can be achieved by applying TTL level signal to all inputs.

|                               |                      | PGM | CE | ŌĒ             | VPP     | Vcc    | $0_0 \sim 0_7$ | POWER  |  |
|-------------------------------|----------------------|-----|----|----------------|---------|--------|----------------|--------|--|
| READ                          | Read                 | Н   | L  | L              |         |        | Data Out       | Active |  |
| OPERATION                     | Output Deselect      | *   | *  | Н              | 5V 5V   |        | High Impedance | Active |  |
| $(Ta = -40 \sim 85^{\circ}C)$ | C) Standby * H *     | 1   |    | High Impedance | Standby |        |                |        |  |
|                               | Program              | L   | L  | Н              |         |        | Data In        | Active |  |
| PROGRAM                       | TION Program Inhibit | *   | Н  | *              | 12.75V  | 0.05)/ | High Impedance |        |  |
| OPERATION<br>(Ta = 25 ± 5°C)  |                      | Н   | L  | Н              |         | 6.25V  | High Impedance |        |  |
| (1a = 25 ± 5 C)               | Program Verify       | н   | L  | L              | 1       |        | Data Out       | ļ      |  |

Note: H; VIH, L; VIL, \*; VIH or VIL

### READ MODE

The TC571000D/TC571001D has three control functions. The chip enable  $(\overline{CE})$  controls the operation power and should be used for device selection. The output enable  $(\overline{OE})$  and the program control  $(\overline{PGM})$  control the output buffers, independent of device selection.

Assuming in that  $\overline{CE} = \overline{OE} = V_{IL}$  and  $\overline{PGM} = V_{IH}$ , the output data is valid at the output after address access time from stabilizing of a laddresses.

The  $\overline{\text{CE}}$  to output valid (t<sub>CE</sub>) is equal to the address access time (t<sub>ACC</sub>).

Assuming that  $\overline{CE} = V_{1L}$ ,  $\overline{PGM} = V_{1H}$  and all addresses are valid, the output data is valid at the outputs after  $t_{OE}$  from the falling edge of  $\overline{OE}$ .

And assuming that  $\overline{CE} = \overline{OE} = V_{1L}$  and all addresses are valid, the output data is valid at the outputs after  $t_{PGM}$  from the rising edge of  $\overline{PGM}$ .

### OUTPUT DESELECT MODE

Assuming that  $\overline{CE} = V_{IH}$  or  $\overline{CIE} = V_{IH}$ , the outputs will be in a high impedance state. So two or more ROMs can be connected together on a common bus line.

When  $\overline{CE}$  is decoded for device selection, all deselected devices are in low power standby mode.

### STANDBY MODE

The TC571000D/TC571001D has a low power standby mode controlled by the  $\overline{CE}$  signal. By applying a high level to the  $\overline{CE}$  input, the TC571000 D/TC571001D is placed in the standby mode which reduce the operating current to  $100\,\mu\text{A}$  by applying MOS-high level (V<sub>CC</sub>) and then the outputs are in a high impedance state, independent of the  $\overline{OE}$  inputs.

#### PROGRAM MODE

Initially, when received by customers, all bits of the TC571000D/TC571001D are in the "1" state which is erased state.

Therefore the program operation is to introduce

"0's" data into the desired bit locations by electrically programming.

The levels required for all inputs are TTL. The TC571000D/TC571001D can be programmed any location at anytime —— either individually, sequentially, or at random.

### PROGRAM VERIFY MODE

The verify mode is to check that the desited data is correctly programmed on the programmed bits.

The verify is accomplished with  $\overline{OE}$  and  $\overline{CE}$  at  $V_{11}$  and  $\overline{PGM}$  at  $V_{1H}$  .

### PROGRAM INHIBIT MODE

Under the condition that the program voltage (+12.75V) is applied to  $V_{PP}$  terminal, a high level  $\overline{CE}$  or  $\overline{PGM}$  input inhibits the TC571000D/TC571001D from being programmed. Programming of two or more EPROMS in parallel with different data is easily accomplished. That is, all inputs except for  $\overline{CE}$  or  $\overline{PGM}$  may be commonly connected, and a TTL low level program pulse is applied to the  $\overline{CE}$  and  $\overline{PGM}$  of the desired device only and TTL high level signal is applied to the other devices.

#### HIGH SPEED PROGRAM OPERATION

The device is set up in the high speed programming mode when the programming voltage (+12.75V) is applied to the  $V_{PF}$  terminal with  $V_{CC}$  = 6.25V and  $\overline{PGM} = V_{IH}$ .

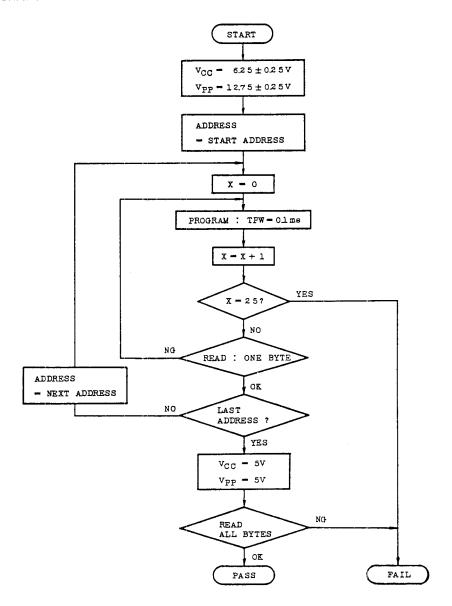
The programming is achieved by applying a single TTL low level 0.1 ms pulse the PGM input after addresses and data are stable. Then the programmed data is verified by using Program Verify Mode.

If the programmed data is not correct, another program pulse of 0.1 ms is applied and then programmed data is verified. This should be repeated until the program operates correctly (max. 25 times).

When programming has been completed, the data in all addresses should be verified with  $V_{CC} = V_{PP} = 5V$ .

# HIGH SPEED PROGRAM OPERATION

• FLOW CHART



### ELECTRIC SIGNATURE MODE

Electric signature mode allows to read out a code from TC571000D/TC571001D which identifies it's manufacturer and device type.

The programming equipment may read out manufacturer code and device code from TC571000D/TC571001D by using this mode before program operation and automatically set program voltage  $\{V_{PP}\}$  and algorithm.

Electric Signature mode is set up when 12V is applied to address line A9 and the rest of address lines is set to  $V_{\rm IL}$  in read operation. Data output in this conditions is manufacturer code. Device code is identified when address A0 is set to  $V_{\rm IH}$ . These two codes possess an odd parity with the parity bit of MSB (07). The following table shows electric signature of TC571000D/TC571001D.

| SIGNATURE        | PINS      | A <sub>0</sub>  | 0, | 06 | 05 | 04 | 03 | O <sub>2</sub> | 01 | 00 | HEX. DATA |
|------------------|-----------|-----------------|----|----|----|----|----|----------------|----|----|-----------|
| Manufacture Code |           | $V_{IL}$        | 1  | 0  | 0  | 1  | 1  | 0              | 0  | 0  | 98        |
| Device Code      | TC571000D | V <sub>IH</sub> | 1  | 0  | 0  | 0  | 0  | 1              | 1  | 0  | 86        |
| Bevice code      | TC571001D |                 | 0  | 0  | 0  | 0  | 0  | 1              | 1  | 1  | 07        |

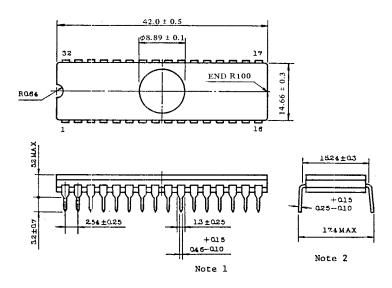
Notes:  $A9 = 12V \pm 0.5V$ 

A1  $\sim$  A8, A10  $\sim$  A16,  $\overline{CE}$ ,  $\overline{OE}$  = V<sub>IL</sub>

PGM = VIH

### **OUTLINE DRAWINGS**

Unit in mm



- NOTE 1. Each lead pitch is 2.54mm. All leads are located within 0.25mm of their true longitudinal position with respect No. 1 and No. 32 leads.
  - 2. This value is measured at the end of leads.
  - 3. All dimensions are in millimeters.